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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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Com	plete if Known ()
Application Number	10/082,397
Filing Date	August 6, 2002
First Named Inventor:	Mark W. Miles
Group Art Unit	2873
Examiner Name	Not yet assigned
Attorney Docket Number	05652.P013XCD

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¹Unique citation designation number. ²See attached Kinds of U.S. Patent Documents. ³Enter Office that issued the document, by the twoletter code (WIPO Standard S.3). ⁴For Japanese patent documents, the indication of the year of reign of the Emperor must precede the serial number of the patent document. ⁵Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. ⁶Applicant is to place a check mark here if English language Translation is attached.

Substitut for Form 1449A/PTO (Modified) Complete if Known **Application Number** 10/082,397 INFORMATION DISCLOSURE Filing Date August 6, 2002 STATEMENT BY APPLICANT First Named Inventor: Mark W. Miles (use as many sheets as necessary) Group Art Unit 2873 **Examiner Name** Not yet assigned 2 2 Sh t of Attorney Docket Number 05652.P013XCD OTHER ART - NO PATENT LITERATURE DOCUMENTS Examiner Cite include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the T² No1 Initials* item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published Science and Technology, The Economist, May 22, 1999, pp. 89-90. then Fan et al., "Channel Drop Filters in Photonic Crystals, "Optics Express, Vol. 3, No. 1, 1998. Mr Giles et al., "A Silicon MEMS Optical Switch Attenuator and Its Use in Lightwave BM Subsystems," IEEE Journal. Joannopoulos et al., Photonic Crystals, "Molding the Flow of Light," copyright 1995. bm Kim et al. "Control of Optical Transmission Through Metals Perforated With Subwave-length m Hole Arrays," Optic Letters, Vol. 24, No. 4, Febru-ary 15, 1999, pp. 256-257. Lin et al., "Free-Space Micromachined Optical Switches for Optical Networking," IEEE Hm Journal of Selected Topics in Quantum Electronics, Vol. 5, No. 1, Jan/Feb. 1999, pp. 4-9. Little et al., "Vertically Coupled Microring Resonator Channel Dropping Filter," IEEE m Photonics Technology Letters, Vol. 11, No. 2, 1999. Magel, "Integrated Optic Devices Using Micromachined Metal Membranes," SPIE Vol. 2686, 0-8194-2060-3/1996. BA Nagami et al., "Plastic Cell Architecture: Towards Reconfigiurable Computing For General-Purpose," IEEE, 0-8186-8900 -5/98, pp. 68-77. MM Zhou et al., "Waveguide Panel Display Using Electromechanist Spatial Modulators" SID lm Digest, Vol. XXIX, 1998.

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STATEMENT BY APPLICANT					First Named Inventor:	Mark W. Miles		
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